74ABT16244A

16-bit buffer/line driver; 3-state

Rev. 8 — 3 November 2011

Product data sheet

General description 1.

The 74ABT16244A high-performance Bipolar CMOS (BiCMOS) device combines low static and dynamic power dissipation with high speed and high output drive.

The 74ABT16244A is a 16-bit buffer that is ideal for driving bus lines. The device features four output enable inputs (10E, 20E, 30E, 40E), each controlling four of the 3-state outputs.

2. Features and benefits

- 16-bit bus interface
- Multiple V_{CC} and GND pins minimize switching noise
- Power-up 3-state
- 3-state buffers
- Output capability: +64 mA and -32 mA
- Live insertion and extraction permitted
- Latch-up performance: JESD 78 Class II
- ESD protection:
 - ♦ HBM JESD-A114E exceeds 2000 V
 - ◆ CDM JESD 22-C101-C exceeds 1000 V

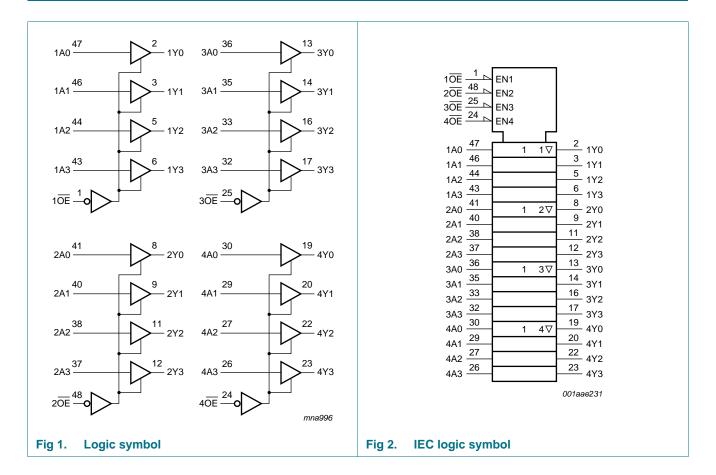
Ordering information 3.

Table 1. **Ordering information**

Type number	Package									
	Temperature range	Name	Description	Version						
74ABT16244ADGG	–40 °C to +85 °C	TSSOP48	plastic thin shrink small outline package; 48 leads; body width 6.1 mm	SOT362-1						
74ABT16244ADL	–40 °C to +85 °C	SSOP48	plastic shrink small outline package; 48 leads; body width 7.5 mm	SOT370-1						

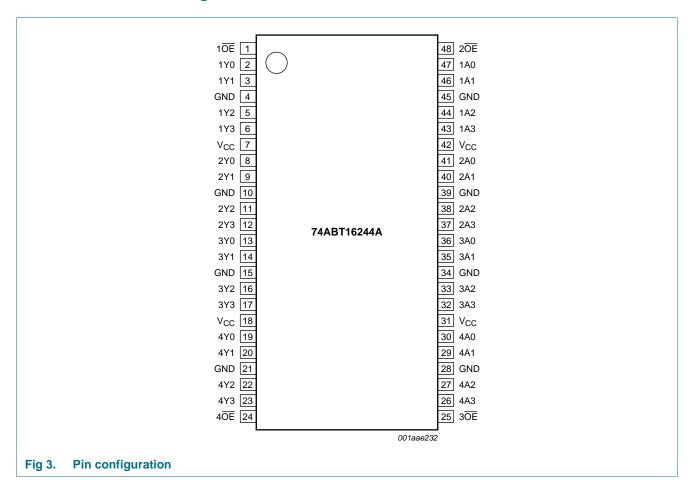


4. Functional diagram



5. Pinning information

5.1 Pinning



5.2 Pin description

Table 2. Pin description

Symbol	Pin	Description
1 OE	1	1 output enable (LOW active)
1Y[0:3]	2, 3, 5, 6	1 data output 0 to output 3
GND	4	ground (0 V)
V_{CC}	7	supply voltage
2Y[0:3]	8, 9, 11, 12	2 data output 0 to output 3
GND	10	ground (0 V)
3Y[0:3]	13, 14, 16, 17	3 data output 0 to output 3
GND	15	ground (0 V)
V_{CC}	18	supply voltage
4Y[0:3]	19, 20, 22, 23	4 data output 0 to output 3
GND	21	ground (0 V)

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 Table 2.
 Pin description ...continued

Symbol	Pin	Description
4 OE	24	4 output enable (LOW active)
3 <mark>OE</mark>	25	3 output enable (LOW active)
GND	28	ground (0 V)
4A[0:3]	30, 29, 27, 26	4 data input 0 to input 3
V _{CC}	31	supply voltage
GND	34	ground (0 V)
3A[0:3]	36, 35, 33, 32	3 data input 0 to input 3
GND	39	ground (0 V)
2A[0:3]	41, 40, 38, 37	2 data input 0 to input 3
V _{CC}	42	supply voltage
GND	45	ground (0 V)
1A[0:3]	47, 46, 44, 43	1 data input 0 to input 3
2 <mark>OE</mark>	48	2 output enable (LOW active)

6. Functional description

Table 3. Function table[1]

Control	Input	Output
nOE	nAn	nYn
L	L	L
	Н	Н
Н	X	Z

^[1] H = HIGH voltage level;

L = LOW voltage level;

7. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Max +7.0 +7.0	Unit V V
+7.0	
	V
+5.5	V
-	mA
-	mA
128	mA
-64	mA
150	°C
+150	°C
	- 128 -64 150

^[1] The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

8. Recommended operating conditions

Table 5. Operating conditions

Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V_{CC}	supply voltage		4.5	-	5.5	V
V _I	input voltage		0	-	V_{CC}	V
V _{IH}	HIGH-level input voltage		2.0	-	-	V
V _{IL}	LOW-level Input voltage		-	-	0.8	V
I _{OH}	HIGH-level output current		-32	-	-	mA
I _{OL}	LOW-level output current		-	-	64	mA
Δt/ΔV	input transition rise and fall rate		-	-	10	ns/V
T_{amb}	ambient temperature	in free air	-40	-	+85	°C

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X = don t care;

Z = high-impedance OFF-state.

^[2] The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction temperatures which are detrimental to reliability.

9. Static characteristics

Table 6. Static characteristics

Symbol	Parameter	Conditions			25 °C		–40 °C t	Unit	
				Min	Тур	Max	Min	Max	
V _{IK}	input clamping voltage	$V_{CC} = 4.5 \text{ V}; I_{IK} = -18 \text{ mA}$		-	-0.9	-1.2	-	-1.2	V
V _{OH}	HIGH-level output	$V_I = V_{IL}$ or V_{IH}							
	voltage	$V_{CC} = 4.5 \text{ V}; I_{OH} = -3 \text{ mA}$		2.5	2.9	-	2.5	-	V
		$V_{CC} = 5.0 \text{ V}; I_{OH} = -3 \text{ mA}$		3.0	3.4	-	3.0	-	V
		$V_{CC} = 4.5 \text{ V}; I_{OH} = -32 \text{ mA}$		2.0	2.4	-	2.0	-	V
V _{OL}	LOW-level output voltage	V_{CC} = 4.5 V; I_{OL} = 64 mA; V_{I} = V_{IL} or V_{IH}		-	0.42	0.55	-	0.55	V
l _l	input leakage current	$V_{CC} = 5.5 \text{ V}; V_I = V_{CC} \text{ or GND}$		-	±0.01	±1.0	-	±1.0	μΑ
I _{OFF}	power-off leakage current	V_{CC} = 0 V; V_{I} or $V_{O} \le 4.5$ V		-	±5.0	±100	-	±100	μА
I _{O(pu/pd)}	power-up/power-down output current	$V_{CC} = 2.0 \text{ V}; V_O = 0.5 \text{ V};$ $V_I = \text{GND or } V_{CC}; n\overline{\text{OE}} = \text{HIGH}$	[1]	-	±5.0	±50	-	±50	μΑ
<u></u>	OFF-state output	$V_{CC} = 5.5 \text{ V}; V_I = V_{IL} \text{ or } V_{IH}$							
	current	output HIGH-state at V _O = 5.5 V		-	0.1	10	-	10	μΑ
		output LOW-state at $V_0 = 0 V$		-	-0.1	-10	-	-10	μΑ
I _{LO}	output leakage current	HIGH-state; $V_O = 5.5 \text{ V}$; $V_{CC} = 5.5 \text{ V}$; $V_I = \text{GND or } V_{CC}$		-	5.0	50	-	50	μΑ
Io	output current	$V_{CC} = 5.5 \text{ V}; V_{O} = 2.5 \text{ V}$	[2]	-50	-100	-180	-50	-180	mΑ
I _{CC}	supply current	V_{CC} = 5.5 V; V_I = GND or V_{CC}							
		outputs HIGH-state		-	0.45	1.0	-	1.0	mΑ
		outputs LOW-state		-	10	19	-	19	mΑ
		outputs 3-state		-	0.45	1.0	-	1.0	mΑ
Δl _{CC}	additional supply current	per input pin; V_{CC} = 5.5 V; one input at 3.4 V and other inputs at V_{CC} or GND	[3][4]	-	100	250	-	250	μА
Cı	input capacitance	$V_I = 0 \text{ V or } V_{CC}$		-	4	-	-	-	pF
C _{I/O}	input/output capacitance	outputs disabled; $V_O = 0 V \text{ or } V_{CC}$		-	7	-	-	-	pF

^[1] This parameter is valid for any V_{CC} between 0 V and 2.1 V, with a transition time of up to 10 ms. From V_{CC} = 2.1 V to V_{CC} = 5 V \pm 10 %, a transition time of up to 100 μ s is permitted.

^[2] Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

^[3] This is the increase in supply current for each input at 3.4 V.

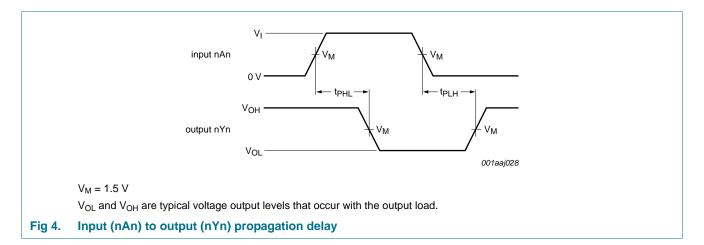
^[4] This data sheet limit may vary among suppliers.

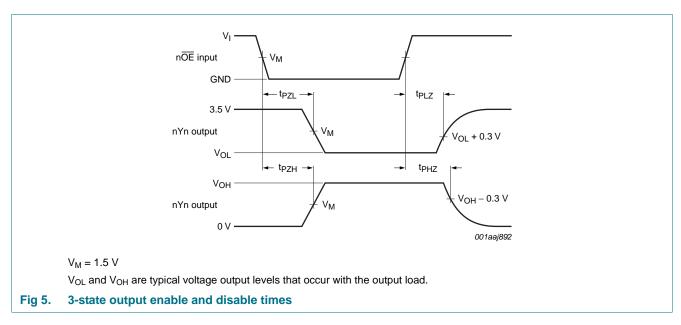
10. Dynamic characteristics

Table 7. Dynamic characteristics GND = 0 V. For test circuit, see Figure 6.

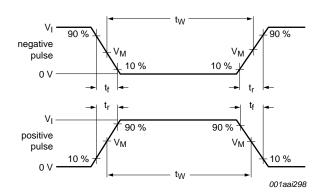
Symbol	Parameter	Conditions	25 °C	; V _{CC} =	5.0 V	-40 °C to V _{CC} = 5.0	Unit	
			Min	Тур	Max	Min	Max	
t _{PLH}	LOW to HIGH propagation delay	nAn to nYn, see Figure 4	1.1	1.7	2.6	1.1	2.8	ns
t _{PHL}	HIGH to LOW propagation delay	nAn to nYn, see Figure 4	1.3	2.1	2.9	1.3	3.4	ns
t _{PZH}	OFF-state to HIGH propagation delay	nOE to nYn; see Figure 5	1.6	2.7	3.7	1.6	4.5	ns
t _{PZL}	OFF-state to LOW propagation delay	nOE to nYn; see Figure 5	2.3	3.5	4.0	2.3	4.8	ns
t _{PHZ}	HIGH to OFF-state propagation delay	nOE to nYn; see Figure 5	1.5	3.0	4.0	1.5	4.6	ns
t _{PLZ}	LOW to OFF-state propagation delay	nOE to nYn; see Figure 5	1.6	2.4	3.2	1.6	4.1	ns

11. Waveforms



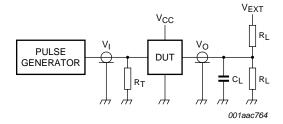


12. Test information



 $V_{M} = 1.5 V$

a. Input pulse definition



Test data is given in Table 8.

Definitions test circuit:

R_L = Load resistance.

 C_L = Load capacitance including jig and probe capacitance.

 R_T = Termination resistance should be equal to output impedance Z_0 of the pulse generator.

b. Test circuit for 3-state outputs

Fig 6. Load circuitry for switching times

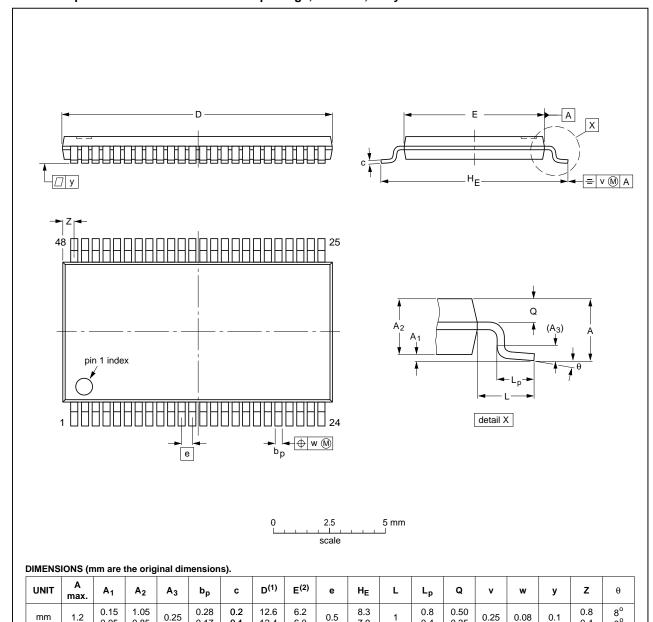
Table 8. Test data

Input				Load		V _{EXT}			
VI	fi	t _W	t _r , t _f	CL	R_L	t _{PHZ} , t _{PZH}	t _{PLZ} , t _{PZL}	t _{PLH} , t _{PHL}	
3.0 V	1 MHz	500 ns	2.5 ns	50 pF	500Ω	open	7.0 V	open	

13. Package outline

TSSOP48: plastic thin shrink small outline package; 48 leads; body width 6.1 mm

SOT362-1



1.2 mm 0.05 0.85

1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.

0.17

12.4

2. Plastic interlead protrusions of 0.25 mm maximum per side are not included.

OUTLINE		REFER	ENCES	EUROPEAN	ISSUE DATE	
VERSION	IEC	JEDEC	JEITA	PROJECTION	1990E DATE	
SOT362-1		MO-153			99-12-27 03-02-19	

7.9

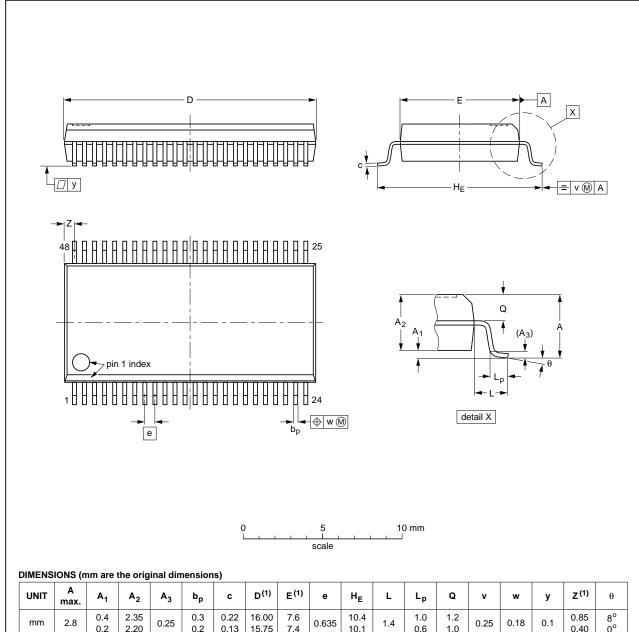
Package outline SOT362-1 (TSSOP48) Fig 7.

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SSOP48: plastic shrink small outline package; 48 leads; body width 7.5 mm

SOT370-1



UNIT	A max.	A ₁	A ₂	A ₃	b _p	С	D ⁽¹⁾	E ⁽¹⁾	е	HE	L	Lp	Q	v	w	у	Z ⁽¹⁾	θ
mm	2.8	0.4 0.2	2.35 2.20	0.25	0.3 0.2	0.22 0.13	16.00 15.75	7.6 7.4	0.635	10.4 10.1	1.4	1.0 0.6	1.2 1.0	0.25	0.18	0.1	0.85 0.40	8° 0°

Note

1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

OUTLINE		REFER	ENCES	EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	JEITA	PROJECTION	ISSUE DATE
SOT370-1		MO-118			99-12-27 03-02-19

Fig 8. Package outline SOT370-1 (SSOP48)

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14. Revision history

Table 9. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
74ABT16244A v.8	20111103	Product data sheet	-	74ABT16244A v.7
Modifications:	Legal pages updated			
74ABT16244A v.7	20100525	Product data sheet	-	74ABT16244A v.6
74ABT16244A v.6	20090323	Product data sheet	-	74ABT16244A v.5
74ABT16244A v.5	20060210	Product data sheet	-	74ABT_H16244A v.4
74ABT_H16244A v.4	19981007	Product specification	-	74ABT_H16244A v.3
74ABT_H16244A v.3	19980225	Product specification	-	74ABT_H16244A v.2

15. Legal information

15.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
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